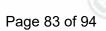


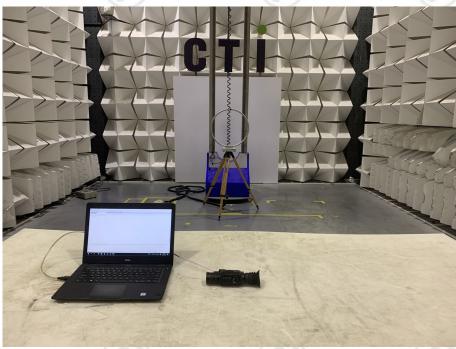
Report No.: EED32M80106501



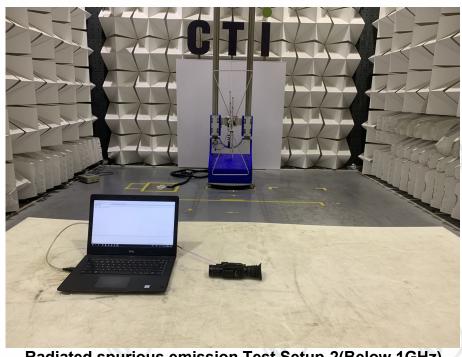


PHOTOGRAPHS OF TEST SETUP

Test model No.: HT60



Radiated spurious emission Test Setup-1(Below 30MHz)



Radiated spurious emission Test Setup-2(Below 1GHz)







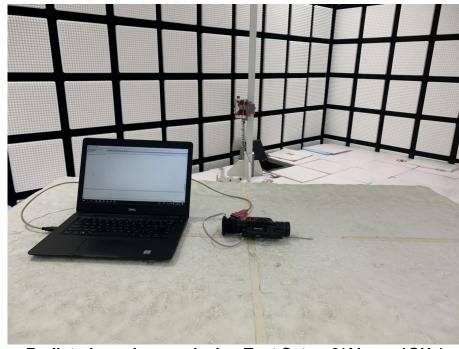




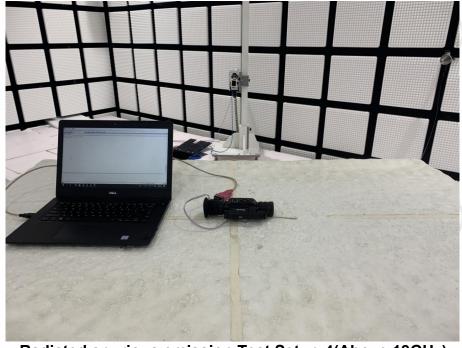


Report No.: EED32M80106501

Page 84 of 94



Radiated spurious emission Test Setup-3(Above 1GHz)



Radiated spurious emission Test Setup-4(Above 18GHz)





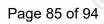








Report No. :EED32M80106501





Radiated spurious emission Test Setup-5(Above 1GHz)
There are absorbing materials under the ground.



Conducted Emissions Test Setup









